## Notice of References Cited Application/Control No. 10/532,305 Examiner Enrique L. Santiago Applicant(s)/Patent Under Reexamination PICCUEZZU ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,818,455	10-1998	Stone et al.	345/619
*	В	US-6,664,959 B2	12-2003	Duluk et al.	345/422
*	C	US-6,985,161 B1	01-2006	Politis, George	345/629
*	D	US-6,958,759 B2	10-2005	Safadi et al.	345/660
*	Ē	US-6,933,955 B2	08-2005	Crocitti et al.	345/666
*	F	US-6,526,577 B1	02-2003	Knudson et al.	725/40
*	G	US-6,518,986 B1	02-2003	Mugura, Kazuto	715/810
*	H	US-6,396,507 B1	05-2002	Kaizuka et al.	345/661
*	١	US-6,377,285 B1	04-2002	Doan et al.	715/764
*	J	US-6,249,290 B1	06-2001	Herndon et al.	345/660
*	K	US-5,754,348	05-1998	Soohoo, Kenneth	359/802
*	L	US-5,729,704	03-1998	Stone et al.	715/804
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν					
	0					
	Ρ	_				
	σ					
	R					
	s					
	T					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.